Receipt date: 02/19/2009

## PTO/SB/08 Equivalent Application No. 10/576 405 INFORMATION DISCLOSURE Filing Date April 30, 2007 First Named Inventor Hada et al. STATEMENT BY APPLICANT Art Unit 1795 (Multiple sheets used when necessary) Examiner Anca Eoff SHEET 1 OF 2 Attorney Docket No. SHIGA7.048APC

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Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
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Examiner Signature Date Considered 03/17/2009 \*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

/Anca Foff/

T1 - Place a check mark in this area when an English language Translation is attached.

Receipt date: 02/19/2009

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Multiple sheets used when necessary) SHEET 2 OF 2 Application No. Filing Date First Named Inv Art Unit At Unit

	P I O/SB/06 Equivalent
Application No.	10/576,405
Filing Date	April 30, 2007
First Named Inventor	Hada et al.
Art Unit	1795
Examiner	Anca Eoff
Attorney Docket No.	SHIGA7.048APC

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T¹
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/A.E./	30	PRZYBILLA K.J. et al., "Hexafluoroacetone in Resist Chemistry: A Versatile New Concept for Materials for Deep UV Lithography", SPIE Vol. 1672 Advances in Resist Technology and Processing IX (1992), pages 500-512.		

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Examiner Signature	/Anca Eoff/	Date Considered	03/17/2009	
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